



INTERNATIONAL STANDARD



**Printed electronics –
Part 301-2: Equipment – Contact printing – Rigid master – Measurement method
of plate master pattern dimension**

INTERNATIONAL
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International Standard IEC 62899-301-2 has been prepared by IEC technical committee TC119: Printed electronics.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
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Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62899 series, published under the general title *Printed electronics*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

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INTRODUCTION

When dissecting the term "printed electronics", it can be easily understood that this industry involves electronic devices and products that are made using some fashion of printing technique. Printing methods have been widely used in textile and paper type substrates for centuries. In the past, the advent of mass producible printouts has brought huge impacts on how knowledge is stored, transferred and reproduced. At this stage of technological development, printing on either rigid or flexible substrates is considered to supplement or replace traditional electronic device manufacturing processes. The difference between media printing and printed electronics stems from the fact that media print is used to convey information for human to process using eyes while printed electronics requires machine to process electronic information; the level of required resolution and functionality make the differences. Some of the widely used functional materials for printed electronics are, but not limited to nano- or micro-size metal particles, semiconductive polymers, and dielectric materials. Due to the available and required readout resolution, small feature size below 20 μm needs to be printed. Layer thickness and registration accuracy of printed products are closely related to quality control of electronic devices, and ink materials require a high level of quality. Overall, printing tolerance is much smaller in printed electronics.

There are mainly two categories in printing process for the printed electronics. One is a non-contact printing process such as inkjet printing and electrostatic discharge (ESD) printing process. The other is a contact printing process such as gravure printing, gravure offset printing, reverse offset printing and screen printing. This document provides a proposal for measuring and assessing the printing master, therefore the scope is limited to the printing process using the printing master.

The quality of the printing master is important because the ink is transferred from the printing master to the substrate directly in these processes and it means that the quality of the results of the printed circuit depends on the quality of the printing master. For a mass production of the printed electronic devices, many companies such as device manufacturers, printing master manufacturers and printing master manufacturing equipment vendors are related to manufacturing and they need to use the printing master and the standardized measurement and assessment methods.

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1 Scope

This part of IEC 62899 defines measurement terms and methods related to the critical dimension of features and the registration accuracy of features on rigid plate masters.

General critical dimensions are defined to evaluate the shape accuracy of features on the plate master. To evaluate the registration accuracy of features on the plate master, the specification for the registration mark for the plate master is specified. Then, common metrology procedures to measure the critical dimensions and the registration accuracy of the plate master are established for device manufacturers, printing master manufacturers and printing master manufacturing equipment vendors. The measurement terms which are measured by agreement between the user and the supplier are measured using the measurement methods given in this document.

2 Normative references

There are no normative references in this document.